

**Search Notes**

Application/Control No.

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Examiner

April Y. Shan

Applicant(s)/Patent under  
Reexamination

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Art Unit

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**SEARCHED**

Class	Subclass	Date	Examiner
726	26	1/6/2008	A.S.
	28	1/6/2008	A.S.

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
text search (see EAST)	1/6/2008	A.S.